

- CASE

# **5<sup>th</sup> Generation CoolSiC<sup>™</sup> 1200V Schottky Diode**

#### SiC Diode

#### **Features**

- Revolutionary semiconductor material Silicon Carbide
- No reverse recovery current / no forward recovery
- Temperature independent switching behaviour
- Low forward voltage even at high operating temperature
- Tight forward voltage distribution
- Excellent thermal performance
- Extended surge current capability
- Specified dv/dt ruggedness
- Pb-free lead plating; RoHS compliant





Pin 1 and backside: Cathode 10 Pin 2: Anode

#### **Potential applications**

- Drives
- Industrial power supplies: Industrial UPS
- Solar central inverters and Solar string inverter

#### **Product validation**

Qualified for industrial applications according to the relevant tests of JEDEC 47/20/22

## **Description**

- System efficiency improvement over Si diodes
- Enabling higher frequency / increased power density solutions
- System size/cost savings due to reduced heatsink requirements and smaller magnetics
- Reduced EMI
- Highest efficiency across the entire load range
- Robust diode operation during surge events
- High reliability
- Related Links: www.infineon.com/SiC









# **Key performance parameters**

Туре	<b>V</b> <sub>DC</sub>	I <sub>F</sub>	<b>Q</b> c	$T_{vj,max}$	Marking	Package
IDK08G120C5	1200 V	8 A	28nC	175°C	D8512C5	PG-TO263-2

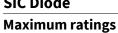


**Table of contents** 

# **Table of contents**

1
3
6
7
10
11

#### **SiC Diode**





#### **Maximum ratings** 1

Note:

For optimum lifetime and reliability, Infineon recommends operating conditions that do not exceed 80% of the maximum ratings stated in this datasheet.

Parameter	Symbol	Value	Unit	
Repetitive peak reverse voltage	$V_{ m RRM}$	1200	V	
<i>T</i> <sub>C</sub> ≥ 25°C	FRRW	1200	·	
Continuous forward current for R <sub>th(j-c,max)</sub>				
$T_{\rm C} = 161^{\circ}{\rm C},  {\rm D}=1$	/ <sub>F</sub>	8.0	А	
$T_c = 135^{\circ}C, D=1$	11-	11.0	A	
$T_{\rm C} = 25^{\circ}{\rm C},  {\rm D}{=}1$		22.8		
Surge repetitive forward current, sine halfwave <sup>1</sup>				
$T_{\rm C}$ =25°C, $t_{\rm p}$ =10ms	$I_{F,RM}$	32	Α	
$T_c=100$ °C, $t_p=10$ ms		24		
Surge non-repetitive forward current, sine halfwave				
$T_{\rm C}$ =25°C, $t_{\rm p}$ =10ms	$I_{F,SM}$	70	Α	
$T_c=150$ °C, $t_p=10$ ms		60		
Non-repetitive peak forward current		530	А	
$T_{\rm C} = 25^{\circ}{\rm C}, t_{\rm p} = 10 \ \mu{\rm s}$	$I_{F,max}$	330	A	
i²t value				
$T_{\rm C} = 25^{\circ}{\rm C}, t_{\rm p} = 10 \text{ ms}$	∫i²dt	25	$A^2s$	
$T_{\rm C} = 150^{\circ} \text{C}, t_{\rm p} = 10 \text{ ms}$		18		
Diode dv/dt ruggedness	du/dt	150	Mas	
V <sub>R</sub> =0960 V	dv/dt	150	V/ns	
Power dissipation for R <sub>th(j-c,max)</sub>		126	<b>NA</b> /	
T <sub>C</sub> = 25°C	$P_{\text{tot}}$	126	W	

<sup>&</sup>lt;sup>1</sup> Not subject to production test. The test was performed with 20000 pulses (two consecutive half-wave rectified sines with 10 ms period).





## **Maximum ratings**

Operating temperature	$T_{ m vj}$	-55175	°C
Storage temperature	$T_{stg}$	-55150	°C
Soldering temperature, reflow soldering (MSL1 according to JEDEC J-STD-020)	$T_{sold}$	260	°C

2021-07-14

## **SiC Diode**





# 2 Thermal resistances

Davamatav	Symbol	Conditions	Value			11
Parameter			min.	typ.	max.	Unit
Characteristic						
Diode thermal resistance, junction – case	$R_{th(j-c)}$		-	0.92	1.19	K/W
Thermal resistance, junction – ambient	$R_{th(j-a)}$	Leaded	-	-	62	K/W

## **Electrical Characteristics**



## 3 Electrical Characteristics

## Static Characteristics, at $T_{\nu j}$ =25°C, unless otherwise specified

Parameter	Symbol	Conditions	Value			Unit
raiailletei	Symbol	Conditions	min.	typ.	max.	Oilit
DC blocking voltage	V <sub>DC</sub>	$T_{\rm vj} = 25^{\circ}\text{C}, I_{\rm R} = 50 \mu\text{A}$	1200	-	-	V
Diode forward voltage	1/	I <sub>F</sub> = 8A, T <sub>vj</sub> =25°C	-	1.65	1.95	V
	$V_{F}$	I <sub>F</sub> = 8A, T <sub>vj</sub> =150°C	-	2.25	-	
Reverse current	1	V <sub>R</sub> =1200V, T <sub>vj</sub> =25°C		3	40	μА
	I <sub>R</sub>	V <sub>R</sub> =1200V, T <sub>vj</sub> =150°C		14	-	

## Dynamic Characteristics, at $T_{\nu j}$ =25°C, unless otherwise specified

Parameter	Symbol	Conditions	Value			Unit
Parameter			min.	typ.	max.	Ullit
Total capacitive charge		V <sub>R</sub> =800V, T <sub>vj</sub> =150°C				
	Qc	$Q_C = \int_0^{V_R} C(V) dV$	-	28	-	nC
		<i>V</i> <sub>R</sub> =1 V, <i>f</i> =1 MHz	-	365	-	
Total Capacitance	С	V <sub>R</sub> =400 V, <i>f</i> =1 MHz	-	26	-	pF
		V <sub>R</sub> =800 V, <i>f</i> =1 MHz	-	20	-	

#### **Electrical Characteristics Diagrams**



## 4 Electrical Characteristics Diagrams

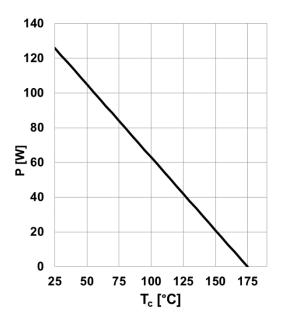


Figure 1. Power dissipation as function of case temperature,  $P_{tot}=f(T_c)$ ,  $R_{th(j-c),max}$ 

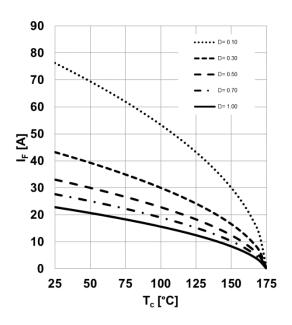


Figure 2. Diode forward current as function of temperature, parameter:  $T_{vj} \le 175^{\circ}\text{C}$ ,  $R_{th(j-c),max}$ , D = duty cycle,  $V_{th}$ ,  $R_{diff}$  @  $T_{vj} = 175^{\circ}\text{C}$ 

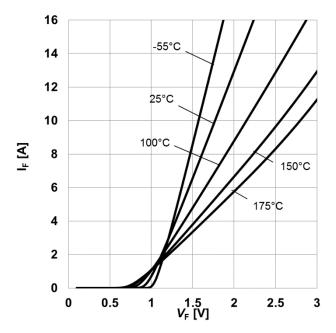


Figure 3. Typical forward characteristics,  $I_F=f(V_F)$ ,  $t_p=10 \mu s$ , parameter:  $T_{vj}$ 

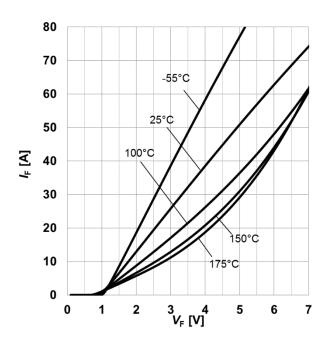
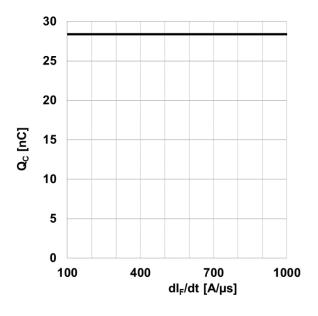


Figure 4. Typical forward characteristics in surge current,  $I_F=f(V_F)$ ,  $t_p=10 \mu s$ , parameter:  $T_{vj}$ 

#### **SiC Diode**

#### **Electrical Characteristics Diagrams**

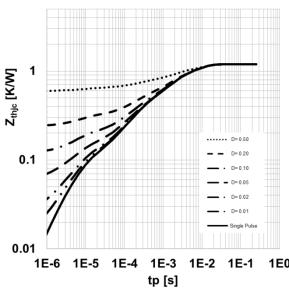




1E-4 1E-5 1E-6 1E-7 1E-8 1E-9 1000 1200 200 400 600 800  $V_R[V]$ 

Figure 5. Typical capacitive charge as function of current slope,  $Q_c=f(dIF/dt)$ *T*<sub>vj</sub>=150°C

Figure 6. Typical reverse characteristics,  $I_R=f(V_R)$ , parameter:  $T_{vj}$ 



1E0

Figure 7. Max. transient thermal impedance,  $Z_{th,j-c}=f(t_P)$ , parameter: D=tP/T

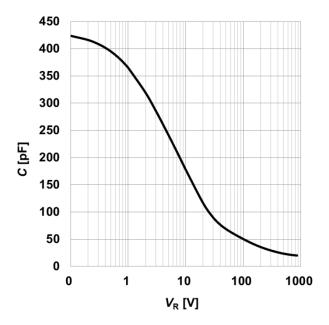


Figure 8. Typical capacitance as function of reverse voltage, C=f(V<sub>R</sub>); T<sub>vj</sub>=25°C; f=1 MHz

# infineon

## **Electrical Characteristics Diagrams**

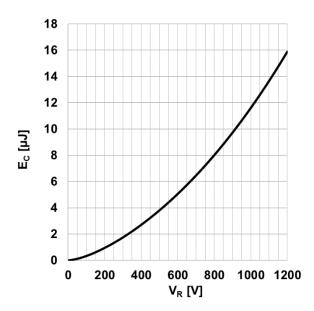


Figure 9. Typical capacitively stored energy as function of reverse voltage,  $E_c=f(V_R)$ 

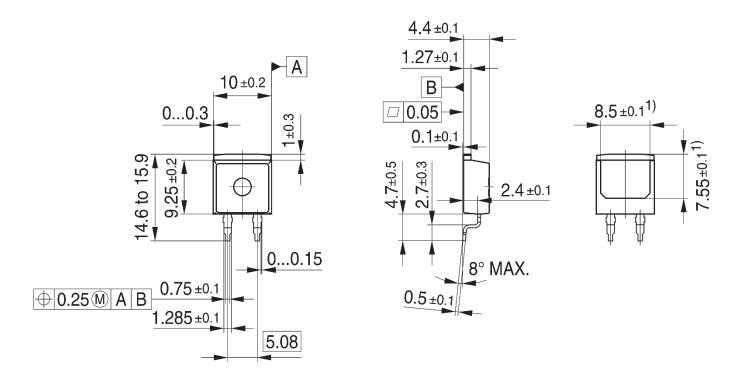
2021-07-14

#### **Package Drawing**



# 5 Package Drawing

#### PG-TO263-2



1) Typical

Metal surface min. X = 7.25, y = 6.9

All metal surfaces: tin plated, except area of cut

All dimensions do not include mold flash or protrusions

All dimensions are in units mm

The drawings is in complicance with ISO 128-30, Projection Method 1 [←♦]

2021-07-14

## SiC-Diode

**Revision history** 



# **Revision history**

Document version	Date of release	Description of changes
V 2.0	2019-10-28	Final Datasheet
V 2.1	2021-07-14	Increased dv/dt ruggedness

#### **Trademarks**

All referenced product or service names and trademarks are the property of their respective owners.

Edition 2021-07-14

Published by

Infineon Technologies AG
81726 München, Germany

© 2021 Infineon Technologies AG. All Rights Reserved.

Do you have a question about this document?

Email: erratum@infineon.com

**Document reference** 

n.a.

#### IMPORTANT NOTICE

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics ("Beschaffenheitsgarantie").

With respect to any examples, hints or any typical values stated herein and/or any information regarding the application of the product, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation warranties of non-infringement of intellectual property rights of any third party.

In addition, any information given in this document is subject to customer's compliance with its obligations stated in this document and any applicable legal requirements, norms and standards concerning customer's products and any use of the product of Infineon Technologies in customer's applications.

The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of customer's technical departments to evaluate the suitability of the product for the intended application and the completeness of the product information given in this document with respect to such application.

For further information on the product, technology delivery terms and conditions and prices please contact your nearest Infineon Technologies office (www.infineon.com).

Please note that this product is not qualified according to the AEC Q100 or AEC Q101 documents of the Automotive Electronics Council.

#### WARNINGS

Due to technical requirements products may contain dangerous substances. For information on the types in question please contact your nearest Infineor Technologies office.

Except as otherwise explicitly approved by Infineor Technologies in a written document signed by authorized representatives of Infineor Technologies, Infineon Technologies' products may not be used in any applications where a failure of the product or any consequences of the use thereof car reasonably be expected to result in personal injury.

# 单击下面可查看定价,库存,交付和生命周期等信息

>>Infineon(英飞凌)